

Search Notes

Application/Control No.

10/069,750

Examiner

George R. Evanisko

Applicant(s)/Patent under
Reexamination

YOON ET AL.

Art Unit

3762

SEARCHED

Class	Subclass	Date	Examiner
same		1/30/2006	

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR